# 8-Bit Serial In/Parallel Out Shift Registers

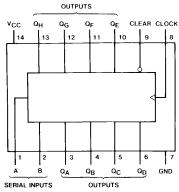
entry of the new data, and resets the first flip-flop to the low level at the next clock pulse, thus providing complete control over incoming data. A high logic level on either input enables the other input, which will then determine the state of the first flip-flop. Data at the serial inputs may be changed while the clock is high or low, but only information meeting the setup and hold time requirements will be entered. Clocking occurs on the low-to-high level transition of the clock input. All inputs are diode-clamped to minimize transmission-line effects.

#### **Features**

- Gated (enable/disable) serial inputs
- Fully buffered clock and serial inputs
- Asynchronous clear
- Typical clock frequency 36 MHz
- Typical power dissipation 80 mW
- Alternate Military/Aerospace device (54LS164) is available. Contact a National Semiconductor Sales Office/ Distributor for specifications.

### **Connection Diagram**

#### **Dual-In-Line Package**



Order Number 54LS164DMQB, 54LS164FMQB, 54LS164LMQB, DM54LS164J, DM54LS164W, DM74LS164M or DM74LS164N See NS Package Number E20A, J14A, M14A, N14A or W14B

#### **Function Table**

Inputs				Outputs				
Clear	Clock	Α	В	QA	$Q_{B}$	$Q_{H}$		
L	Х	Х	Х	L	L		Г	
Н	L	Х	Χ	Q <sub>A0</sub>	$Q_{B0}$		Q <sub>H0</sub>	
Н	↑	Н	Н	Н	$Q_{An}$		$Q_{Gn}$	
Н	↑	L	Χ	L	$Q_{An}$		$Q_{Gn}$	
Н	↑	Х	L	L	$Q_{An}$		Q <sub>Gn</sub>	

H = High Level (steady state), L = Low Level (steady state)

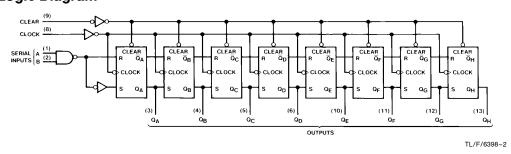
X = Don't Care (any input, including transitions)

↑ = Transition from low to high level

 $Q_{A0}$ ,  $Q_{B0}$ ,  $Q_{H0}$  = The level of  $Q_{A}$ ,  $Q_{B}$ , or  $Q_{H}$ , respectively, before the indicated steady-state input conditions were established.

 $Q_{An}$ ,  $Q_{Gn}=$  The level of  $Q_A$  or  $Q_G$  before the most recent  $\uparrow$  transition of the clock; indicates a one-bit shift.

#### **Logic Diagram**



#### **Absolute Maximum Ratings (Note)**

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage 7V
Input Voltage 7V
Operating Free Air Temperature Range

Storage Temperature Range  $-65^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ 

Note: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" tables will define the conditions for actual device operation.

# **Recommended Operating Conditions**

Symbol	Parameter		ı	DM54LS164			DM74LS164		
Syllibol			Min	Nom	Max	Min	Nom	Max	Units
V <sub>CC</sub>	Supply Voltage		4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High Level Input Volt	High Level Input Voltage				2			V
V <sub>IL</sub>	Low Level Input Voltage				0.7			0.8	V
IOH	High Level Output Current				-0.4			-0.4	mA
l <sub>OL</sub>	Low Level Output Current				4			8	mA
f <sub>CLK</sub>	Clock Frequency (Note 4)		0		25	0		25	MHz
t <sub>W</sub>	Pulse Width (Note 4)	Clock	20			20			ns
		Clear	20			20			
t <sub>SU</sub>	Data Setup Time (Note 4)		17			17			ns
t <sub>H</sub>	Data Hold Time (Note 4)		5			5			ns
t <sub>REL</sub>	Clear Release Time (Note 4)		30			30			ns
T <sub>A</sub>	Free Air Operating Te	Free Air Operating Temperature			125	0		70	°C

# **Electrical Characteristics** over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ (Note 1)	Max	Units		
VI	Input Clamp Voltage	$V_{CC} = Min, I_{I} = -18 \text{ mA}$				-1.5	V	
V <sub>OH</sub> High Level Out	High Level Output	V <sub>CC</sub> = Min, I <sub>OH</sub> = Max	DM54	2.5	3.4		v	
	Voltage	V <sub>IL</sub> = Max, V <sub>IH</sub> = Min	DM74	2.7	3.4			
V <sub>OL</sub> Low L	Low Level Output	V <sub>CC</sub> = Min, I <sub>OL</sub> = Max	DM54		0.25	0.4	V	
	Voltage	$V_{IL} = Max, V_{IH} = Min$	DM74		0.35	0.5		
		I <sub>OL</sub> = 4 mA, V <sub>CC</sub> = Min	DM74		0.25	0.4		
II	Input Current @ Max Input Voltage	$V_{CC} = Max, V_I = 7V$				0.1	mA	
I <sub>IH</sub>	High Level Input Current	$V_{CC} = Max, V_I = 2.7V$				20	μΑ	
	Low Level Input Current	$V_{CC} = Max, V_I = 0.4V$				-0.4	mA	
los	Short Circuit	V <sub>CC</sub> = Max	DM54	-20		-100	mA	
	Output Current	(Note 2)	DM74	-20		-100	"	
Icc	Supply Current	V <sub>CC</sub> = Max (Note 3)			16	27	mA	

Note 1: All typicals are at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ .

Note 2: Not more than one output should be shorted at a time, and the duration should not exceed one second.

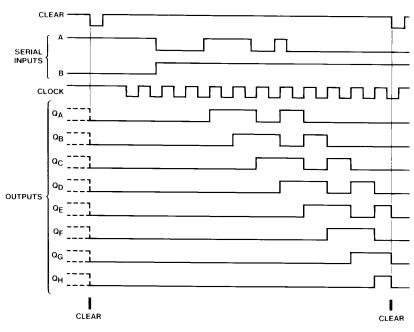
Note 3: I<sub>CC</sub> is measured with all outputs open, the SERIAL input grounded, the CLOCK input at 2.4V, and a momentary ground, then 4.5V, applied to the CLEAR input.

Note 4:  $T_A = 25^{\circ}C$  and  $V_{CC} = 5V$ .

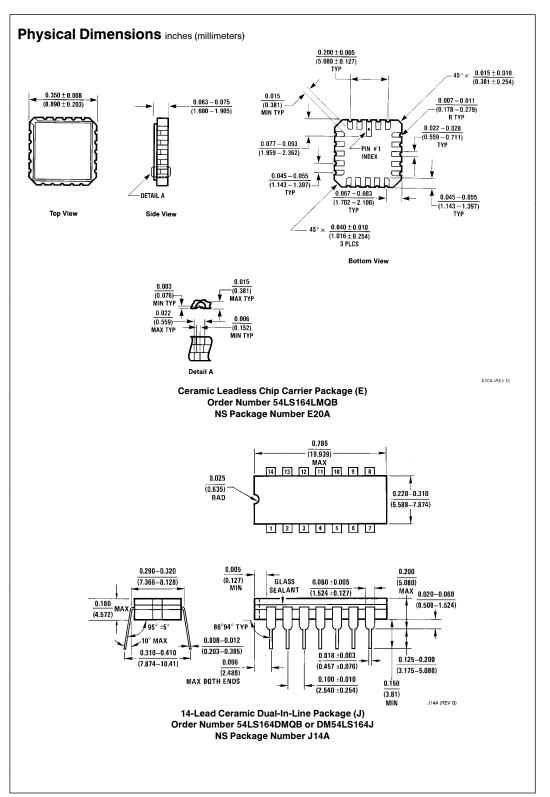
Switching Characteristics	$_{\rm CC} = 5$ V and $_{\rm A} = 25$ °C (See Section 1 for Test Waveforms and Output Load)
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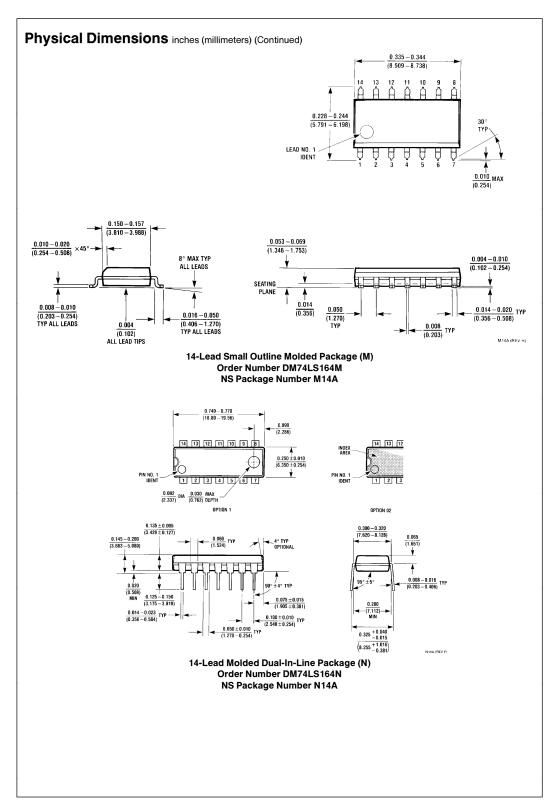
		From (Input) To (Output)					
Symbol	Parameter		$C_L = 15 pF$		C <sub>L</sub> = 50 pF		Units
		, , ,	Min	Max	Min	Max	
f <sub>MAX</sub>	Maximum Clock Frequency		25				MHz
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	Clock to Output		27		30	ns
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	Clock to Output		32		40	ns
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	Clear to Output		36		45	ns

# **Timing Diagram**

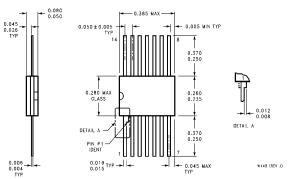


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## Physical Dimensions inches (millimeters) (Continued)



14-Lead Ceramic Flat Package (W) Order Number 54LS164FMQB or DM54LS164W NS Package Number W14B

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